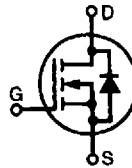


HiPerFET™ Power MOSFETs

N-Channel Enhancement Mode
High dv/dt, Low t_{rr}, HDMOS™ Family

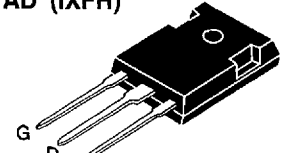
IXFH/FM 42N20
IXFH/FM 50N20
IXFH 58N20

V _{DSS}	I _{D25}	R _{DS(on)}	t _{rr}
200 V	42 A	60 mΩ	200 ns
200 V	50 A	45 mΩ	200 ns
200 V	58 A	40 mΩ	200 ns

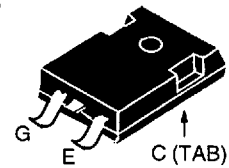


Symbol	Test Conditions	Maximum Ratings	
V _{DSS}	T _J = 25°C to 150°C	200	V
V _{DGR}	T _J = 25°C to 150°C; R _{GS} = 1 MΩ	200	V
V _{GS}	Continuous	±20	V
V _{GSM}	Transient	±30	V
I _{D25}	T _C = 25°C	42N20	42 A
		50N20	50 A
		58N20	58 A
I _{DM}	T _C = 25°C, pulse width limited by T _{JM}	42N20	168 A
		50N20	200 A
		58N20	232 A
I _{AR}	T _C = 25°C	42N20	42 A
		50N20	50 A
		58N20	58 A
E _{AR}	T _C = 25°C	30	mJ
dv/dt	I _S ≤ I _{DM} , di/dt ≤ 100 A/μs, V _{DD} ≤ V _{DSS} , T _J ≤ 150°C, R _G = 2 Ω	5	V/ns
P _D	T _C = 25°C	300	W
T _J		-55 ... +150	°C
T _{JM}		150	°C
T _{stg}		-55 ... +150	°C
M _d	Mounting torque	1.13/10	Nm/lb.in.
Weight		TO-204 = 18 g, TO-247 = 6 g	
Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s		300	°C

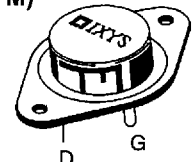
TO-247 AD (IXFH)



TO-247 SMD
("S" Suffix)
(Note 1)



TO-204 AE (IXFM)



G = Gate D = Drain
S = Source TAB = Drain

Features

- International standard packages
- Low R_{DS(on)} HDMOS™ process
- Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
- easy to drive and to protect
- Fast intrinsic Rectifier

Applications

- DC-DC converters
- Synchronous rectification
- Battery chargers
- Switched-mode and resonant-mode power supplies
- DC choppers
- AC motor control
- Temperature and lighting controls
- Low voltage relays

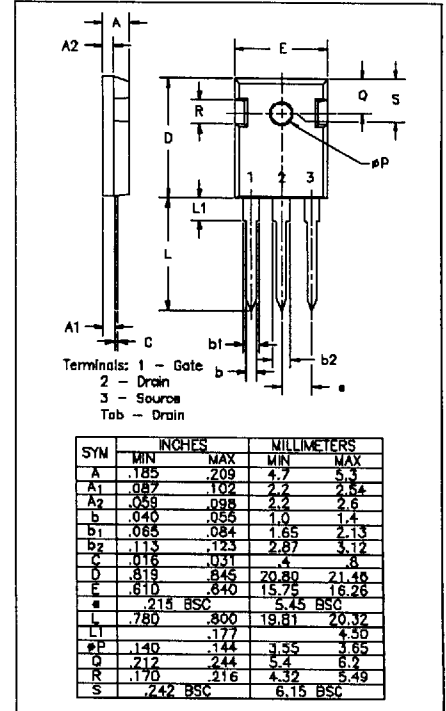
Advantages

- Easy to mount with 1 screw (TO-247) (isolated mounting screw hole)
- Space savings
- High power density

Symbol	Test Conditions	Characteristic Values (T _J = 25°C, unless otherwise specified)		
		Min.	Typ.	Max.
V _{DSS}	V _{GS} = 0 V, I _D = 250 μA	200		V
V _{GS(th)}	V _{DS} = V _{GS} , I _D = 4 mA	2		V
I _{GSS}	V _{GS} = ±20 V _{DC} , V _{DS} = 0			±100 nA
I _{DSS}	V _{DS} = 0.8 V _{DSS} V _{GS} = 0 V	T _J = 25°C		200 μA
		T _J = 125°C		1 mA

Symbol	Test Conditions	Characteristic Values		
		Min.	Typ.	Max.
$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 0.5 I_{D25}$ 42N20 50N20 58N20 Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle $\delta \leq 2\%$			0.060 Ω 0.045 Ω 0.040 Ω
g_{fs}	$V_{DS} = 10\text{ V}; I_D = 0.5 I_{D25}$, pulse test	26	32	S
C_{iss}	$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$		4400	pF
C_{oss}			800	pF
C_{rss}			285	pF
$t_{d(on)}$	$V_{GS} = 10\text{ V}, V_{DS} = 0.5 V_{DSS}, I_D = 0.5 I_{D25}$ $R_G = 1\ \Omega$ (External)		18	ns
t_r			15	ns
$t_{d(off)}$			72	ns
t_f			16	ns
$Q_{g(on)}$	$V_{GS} = 10\text{ V}, V_{DS} = 0.5 V_{DSS}, I_D = 0.5 I_{D25}$		190	nC
Q_{gs}			35	nC
Q_{gd}			95	nC
R_{thJC}			0.42	K/W
R_{thCK}		0.25		K/W

TO-247 AD (IXFH) Outline



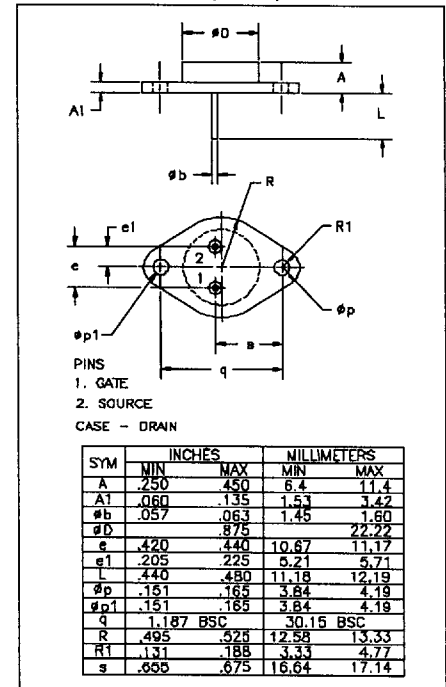
Source-Drain Diode

Characteristic Values
($T_J = 25^\circ\text{C}$, unless otherwise specified)

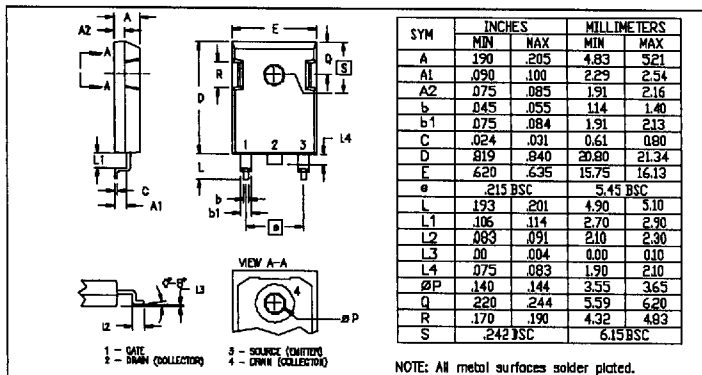
Symbol	Test Conditions	Characteristic Values		
		Min.	Typ.	Max.
I_S	$V_{GS} = 0$	42N20 50N20 58N20		42 A 50 A 58 A
I_{SM}	Repetitive; pulse width limited by T_{JM}	42N20 50N20 58N20		168 A 200 A 232 A
V_{SD}	$I_F = I_S, V_{GS} = 0\text{ V}$, Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle $\delta \leq 2\%$			1.5 V
t_{rr}	$I_F = 25\text{ A}$, $-di/dt = 100\text{ A}/\mu\text{s}$, $V_R = 100\text{ V}$	$T_J = 25^\circ\text{C}$		200 ns
		$T_J = 125^\circ\text{C}$		300 ns
Q_{RM}		$T_J = 25^\circ\text{C}$	1.5	μC
		$T_J = 125^\circ\text{C}$	2.6	μC
I_{RM}		$T_J = 25^\circ\text{C}$	19	A
		$T_J = 125^\circ\text{C}$	23	A

Note 1: Add "S" suffix for TO-247 SMD package option (EX: IXFH50N20S)

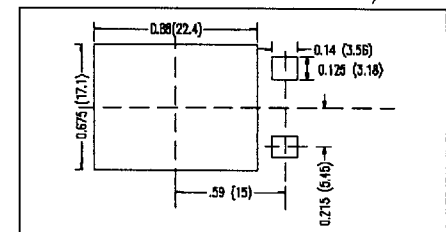
TO-204AE (IXFM) Outline



TO-247 SMD Outline



Min. Recommended Footprint Dimensions in inches and mm)



IXYS reserves the right to change limits, test conditions, and dimensions.

Fig. 1. Output Characteristics

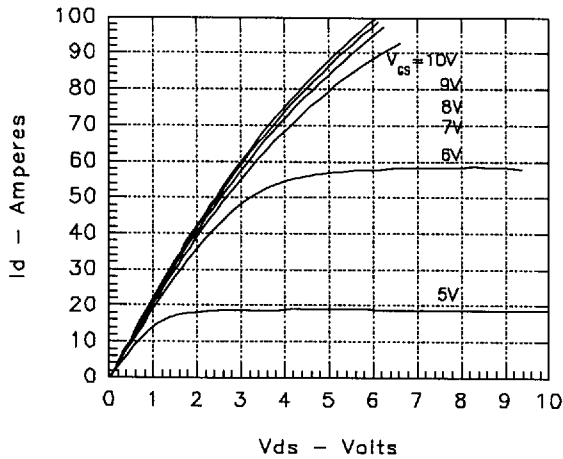


Fig. 2. Input Admittance

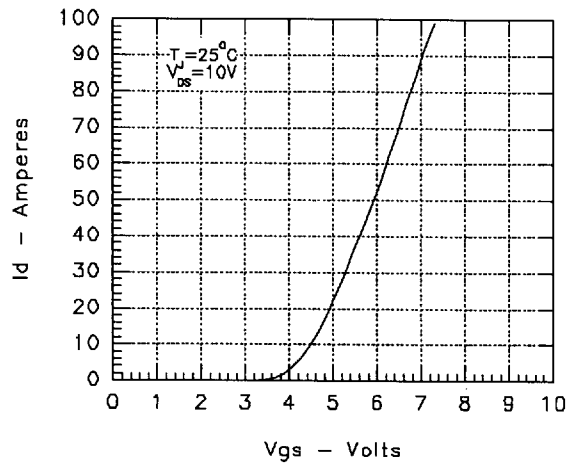


Fig. 3. Rds(on) vs. Drain Current

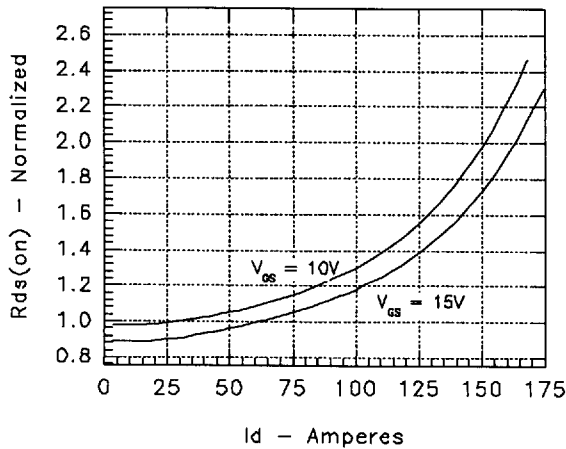


Fig. 4. Temperature Dependence of Drain to Source Resistance

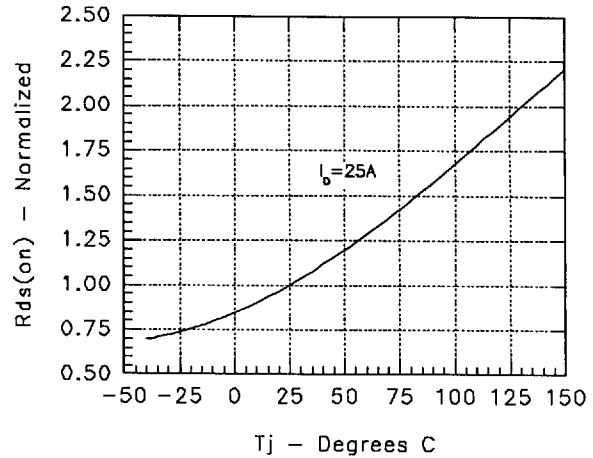


Fig. 5. Drain Current vs. Case Temperature

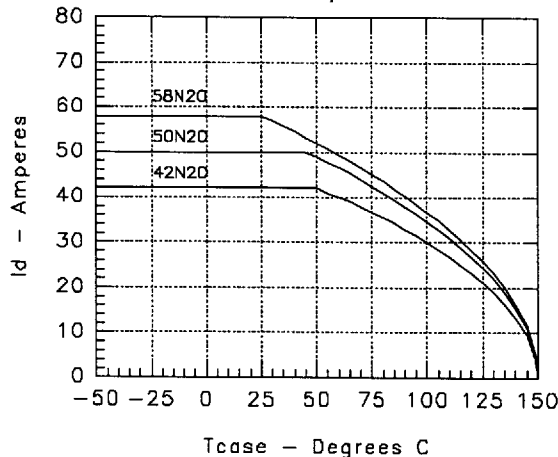
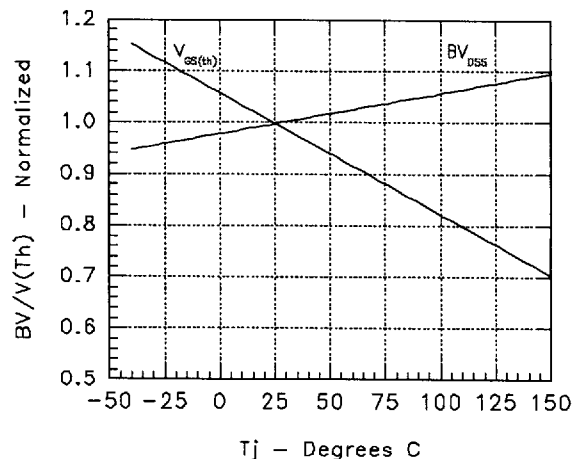


Fig. 6. Temperature Dependence of Breakdown Voltage and Threshold Voltage



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Fig. 7. Gate Charge

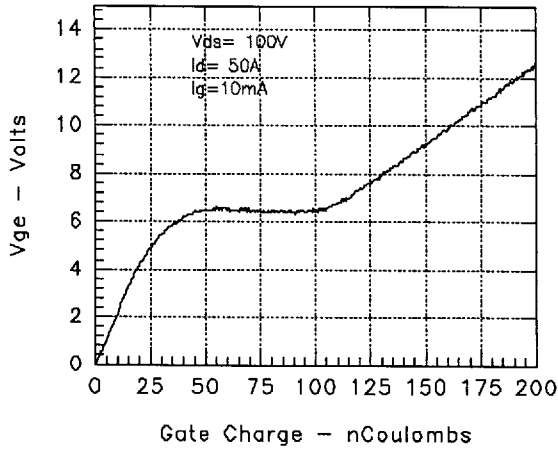


Fig. 8. Forward Bias Safe Operating Area

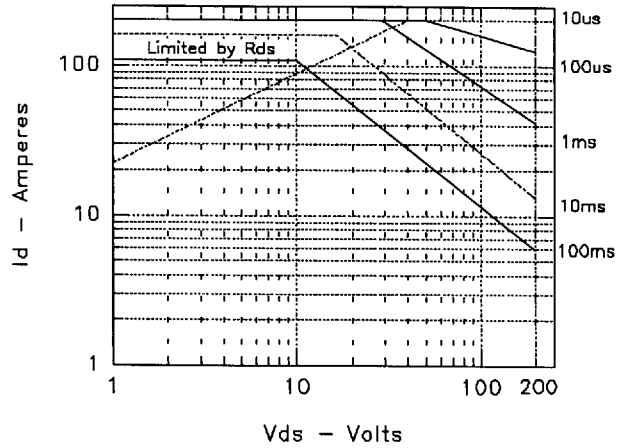


Fig. 9. Capacitance Curves

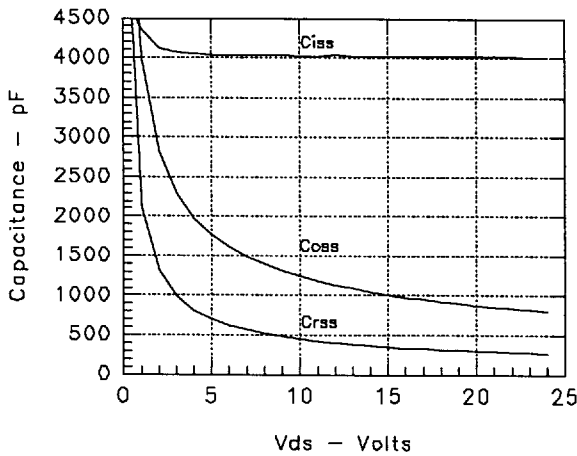


Fig. 10. Source Current vs. Source to Drain Voltage

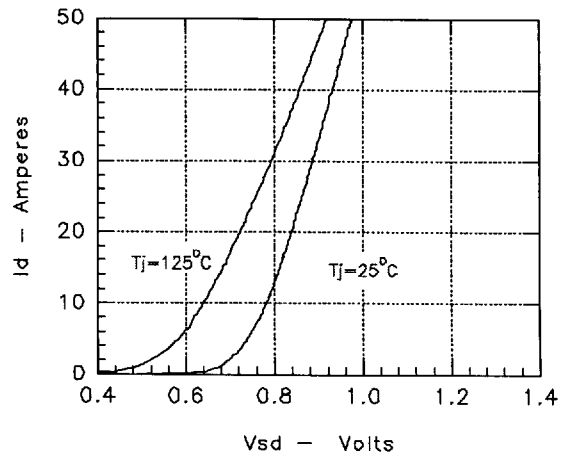
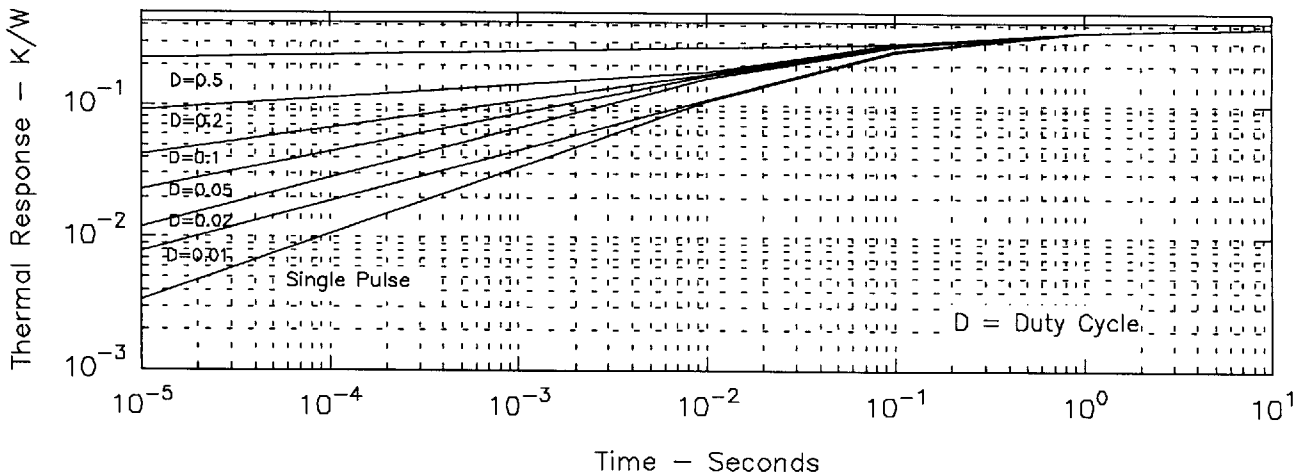


Fig. 11. Transient Thermal Impedance



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